

Search Notes

Application/Control No.

10/717,895

Examiner

David Mis

Applicant(s)/Patent under
Reexamination

MATSUO ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
331	36C,	5/17/2005	DM
	74-77,		
	96,		
	117R,		
	117FE,		
	117D,		
	171,		
	177V		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner